

Notice of References Cited	Application/Control No. 10/567,117		Applicant(s)/Patent Under Reexamination FUJIWARA ET AL.	
	Examiner JOHN S. CHU		Art Unit 1795	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0091929 A1	05-2003	Nishi et al.	430/270.1
*	B	US-7,179,578 B2	02-2007	Sato et al.	430/270.1
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	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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